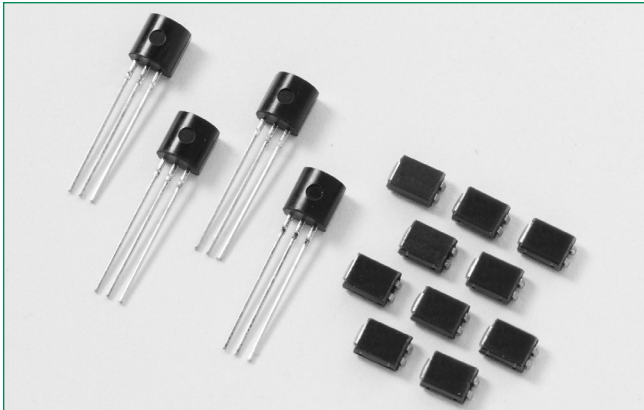


EC103xx & SxSx Series

Description

Excellent unidirectional switches for phase control applications such as heating and motor speed controls.

Sensitive gate SCRs are easily triggered with microAmps of current as furnished by sense coils, proximity switches, and microprocessors.

Features & Benefits

- RoHS compliant
- Glass – passivated junctions
- Voltage capability up to 600 V
- Surge capability up to 20 A

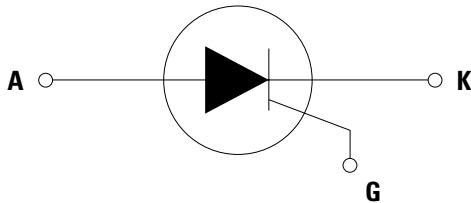
Main Features

| Symbol | Value | Unit |
|-------------------|------------|---------|
| $I_{T(RMS)}$ | 0.8 | A |
| V_{DRM}/V_{RRM} | 400 to 600 | V |
| I_{GT} | 12 to 500 | μ A |

Applications

Typical applications are capacitive discharge systems for strobe lights and gas engine ignition. Also controls for power tools, home/brown goods and white goods appliances.

Schematic Symbol



Additional Information


[Datasheet](#)

[Resources](#)

[Samples](#)

Absolute Maximum Ratings – Sensitive SCRs

| Symbol | Parameter | Test Conditions | Value | Unit |
|--------------|---|--|------------|------------------------|
| $I_{T(RMS)}$ | RMS on-state current | $T_c = 75^\circ\text{C}$ | 0.8 | A |
| $I_{T(AV)}$ | Average on-state current | $T_c = 75^\circ\text{C}$ | 0.51 | A |
| I_{TSM} | Peak non-repetitive surge current | single half cycle; $f = 50\text{Hz}$; $T_J(\text{initial}) = 25^\circ\text{C}$ | 16 | A |
| | | single half cycle; $f = 60\text{Hz}$; $T_J(\text{initial}) = 25^\circ\text{C}$ | 20 | |
| I^2t | I^2t Value for fusing | $t_p = 8.3 \text{ ms}$ | 1.6 | A^2s |
| di/dt | Critical rate of rise of on-state current | $f = 60 \text{ Hz}; T_J = 110^\circ\text{C}$ | 50 | $\text{A}/\mu\text{s}$ |
| I_{GM} | Peak gate current | $T_J = 110^\circ\text{C}$ | 1 | A |
| $P_{G(AV)}$ | Average gate power dissipation | $T_J = 110^\circ\text{C}$ | 0.1 | W |
| T_{stg} | Storage temperature range | | -40 to 150 | $^\circ\text{C}$ |
| T_J | Operating junction temperature range | | -40 to 110 | $^\circ\text{C}$ |

Electrical Characteristics ($T_J = 25^\circ\text{C}$, unless otherwise specified)

| Symbol | Test Conditions | | Value | | | | Unit |
|-----------|---|------|-----------------|-----------------|---------------------------|-----------------|------------------|
| | | | SxS1 EC103X1 | SxS2 EC103X2 | SxS / 2N6565 EC103X | SxS3 EC103X3 | |
| I_{GT} | $V_D = 6\text{V}; R_L = 100\ \Omega$ | MAX. | 12 | 50 | 200 | 500 | μA |
| V_{GT} | | MAX. | 0.8 | | | | V |
| V_{GRM} | $I_{RG} = 10\ \mu\text{A}$ | MIN. | 5 | | | | V |
| dv/dt | $V_D = V_{DRM}; R_{GK} = 1\ \text{k}\Omega$ | 400V | 20 | 25 | 30 | 40 | V/ μs |
| | | 600V | 10 | 10 | 15 | 20 | |
| V_{GD} | $V_D = V_{DRM}; R_L = 3.3\ \text{k}\Omega; T_J = 110^\circ\text{C}$ | MIN. | 0.2 | 0.25 | | | V |
| I_H | $I_T = 20\ \text{mA}$ (initial), $R_{GK} = 1\ \text{k}\Omega$ | MAX. | 5 | | | 8 | mA |
| t_q | (1) | MAX. | 60 | | 50 | 45 | μs |
| t_{gt} | $I_G = 2 \times I_{GT}; \text{PW} = 15\ \mu\text{s}; I_T = 1.6\ \text{A}$ | TYP. | 2 | 5 | 20 | 30 | μs |

1. $I_T = 1\ \text{A}; t_q = 50\ \mu\text{s}; \text{dv/dt} = 5\ \text{V}/\mu\text{s}; \text{di/dt} = 5\ \text{A}/\mu\text{s}$

Static Characteristics

| Symbol | Test Conditions | | Value | Unit | |
|---------------------|---|---------------------------|-------|------|---------------|
| V_{TM} | $I_T = 1.2\ \text{A}; t_p = 380\ \mu\text{s}$ | | MAX. | 1.4 | V |
| I_{DRM} / I_{RRM} | $V_{DRM} = V_{RRM}$ $R_{GK} = 1\ \text{k}\Omega$ | $T_J = 25^\circ\text{C}$ | MAX. | 1 | μA |
| | | $T_J = 100^\circ\text{C}$ | | 50 | |
| | | $T_J = 110^\circ\text{C}$ | | 100 | |

Thermal Resistances

| Symbol | Parameter | | Value | Unit |
|-------------------|-----------------------|----------------|-------|---------------------------|
| $R_{\theta(J-C)}$ | Junction to case (AC) | EC103xy/2N6565 | 75 | $^\circ\text{C}/\text{W}$ |
| | | SxSy | 60* | |
| $R_{\theta(J-A)}$ | Junction to ambient | EC103xy/2N6565 | 160 | $^\circ\text{C}/\text{W}$ |

Notes: x = voltage, y = sensitivity

* = Mounted on 1 cm² copper (two-ounce) foil surface

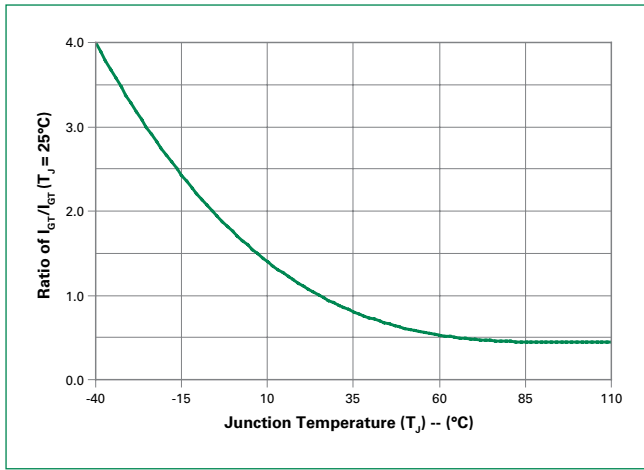
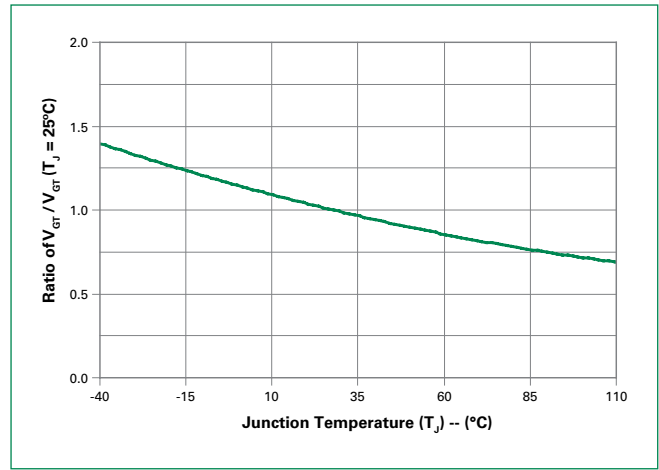
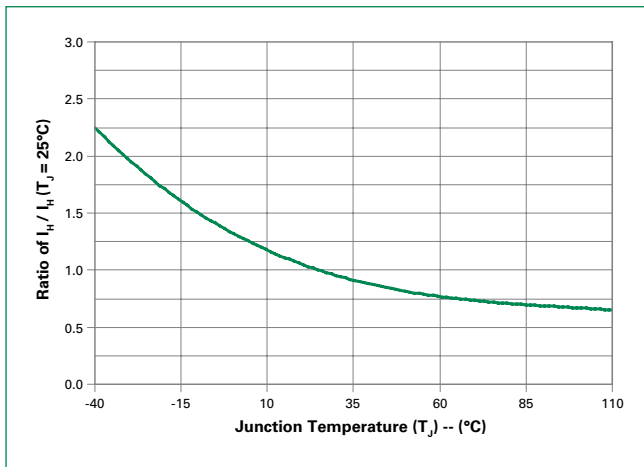
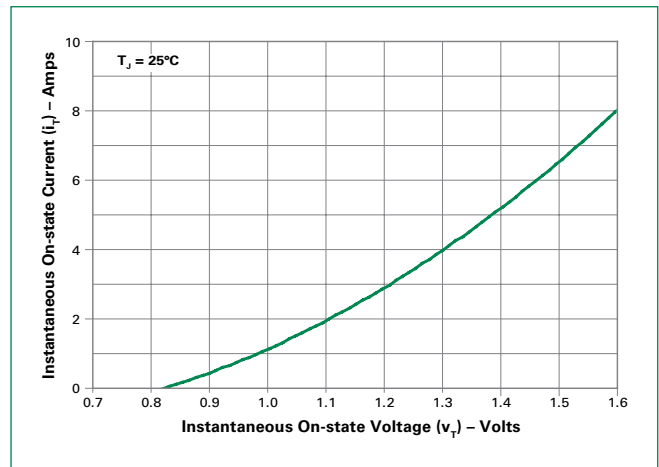
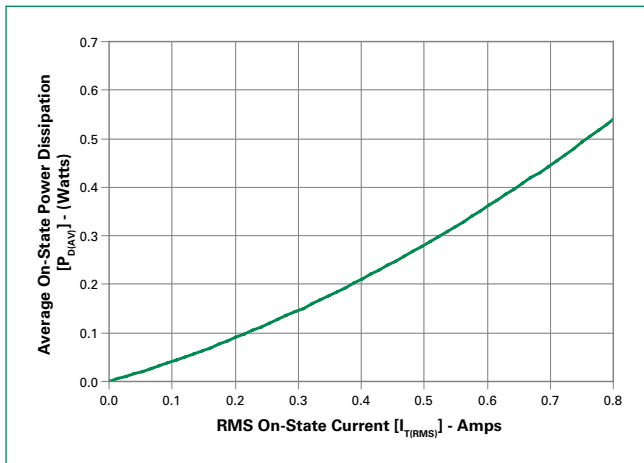
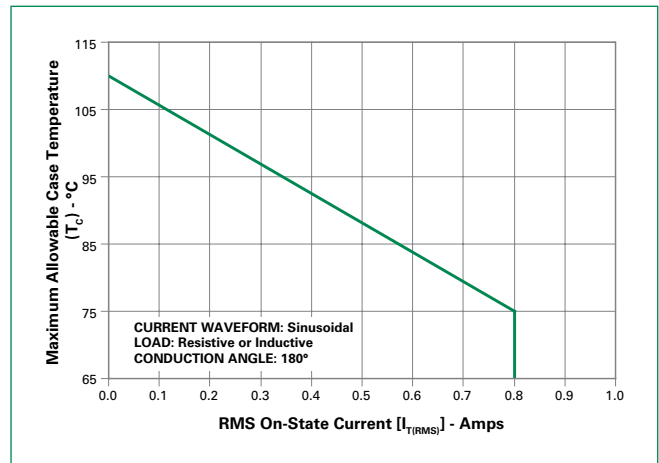
Figure 1: Normalized DC Gate Trigger Current vs. Junction Temperature

Figure 2: Normalized DC Gate Trigger Voltage vs. Junction Temperature

Figure 3: Normalized DC Holding Current vs. Junction Temperature

Figure 4: On-State Current vs. On-State Voltage (Typical)

Figure 5: Power Dissipation (Typical) vs. RMS On-State Current

Figure 6: Maximum Allowable Case Temperature vs. RMS On-State Current


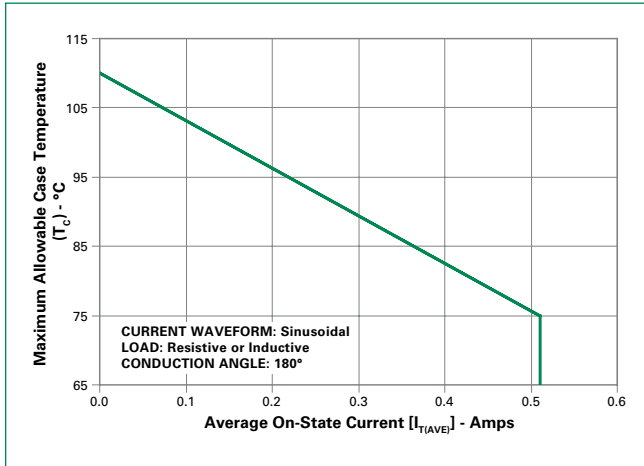
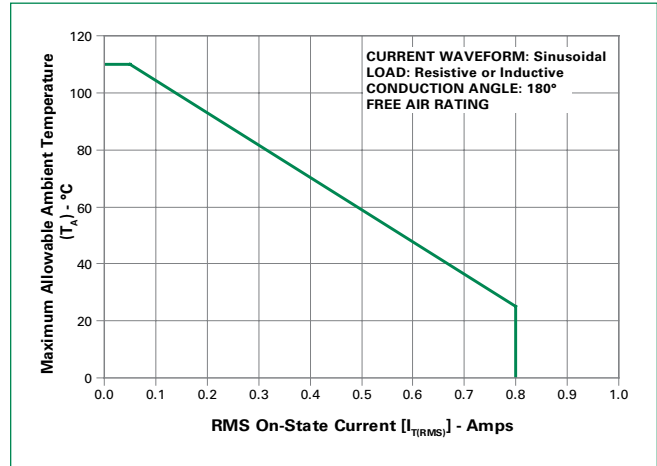
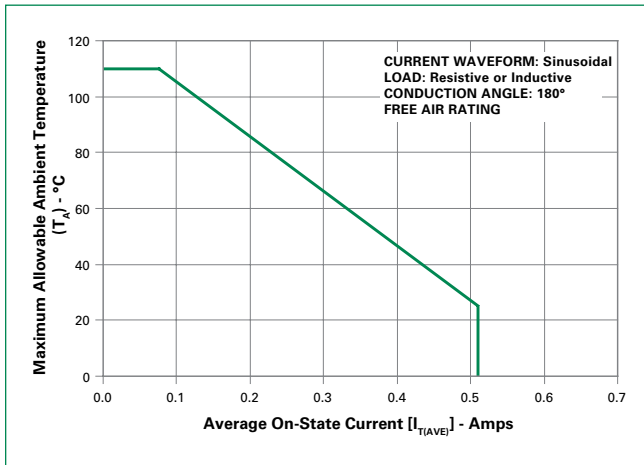
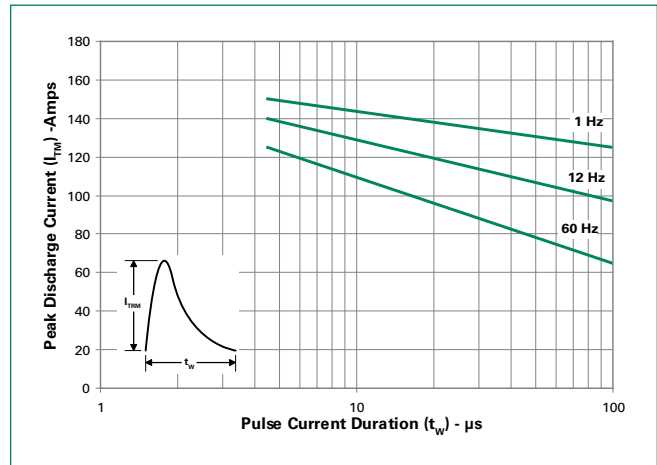
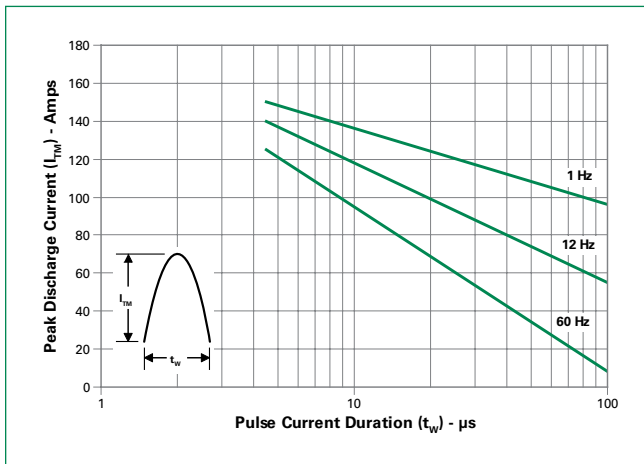
Figure 7: Maximum Allowable Case Temperature vs. Average On-State Current

Figure 8: Maximum Allowable Ambient Temperature vs. RMS On-State Current

Figure 9: Maximum Allowable Ambient Temperature vs. Average On-State Current

Figure 10: Peak Capacitor Discharge Current

Figure 11: Peak Repetitive Sinusoidal Pulse Current


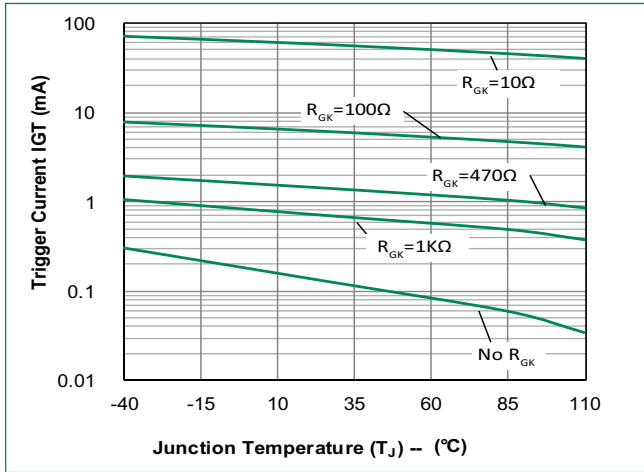
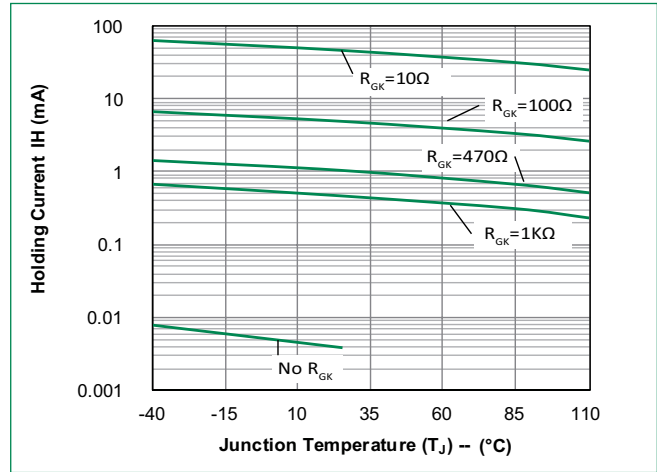
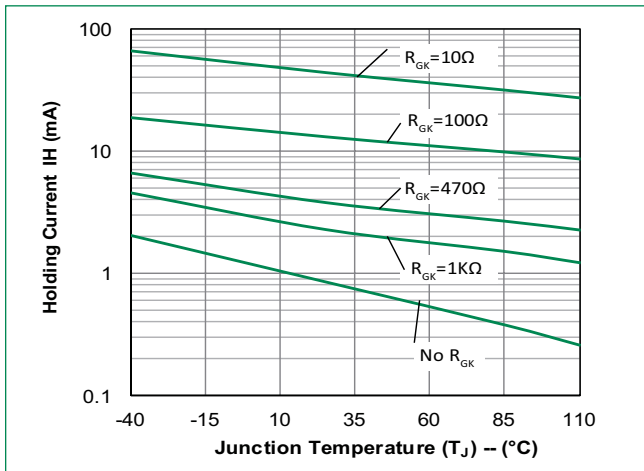
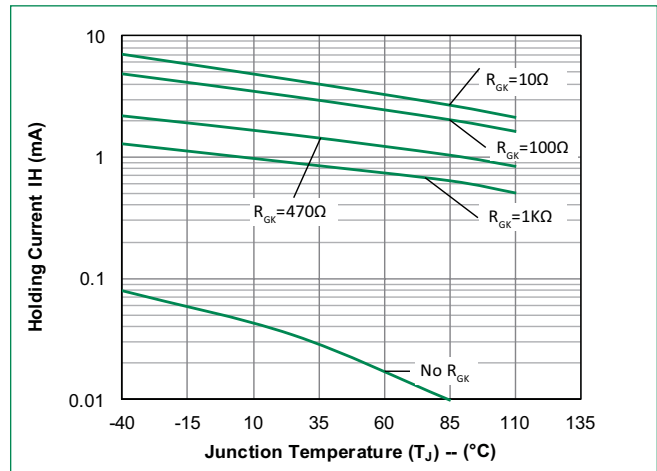
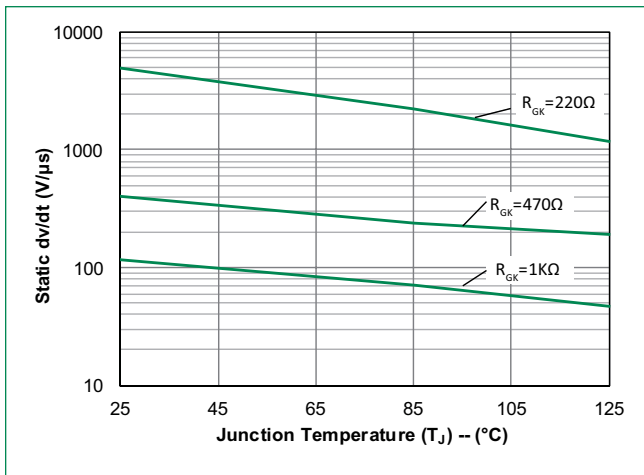
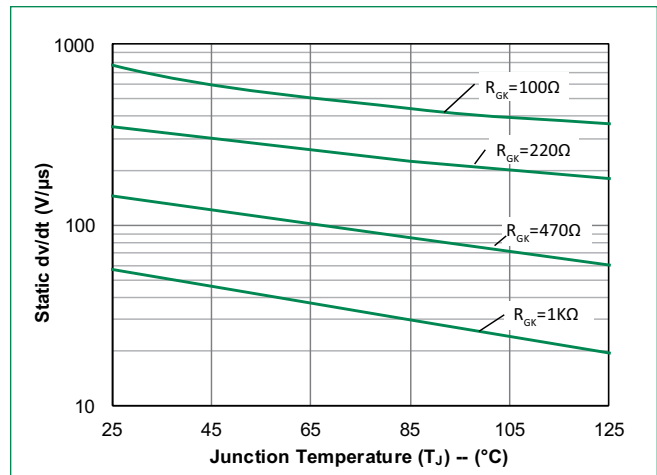
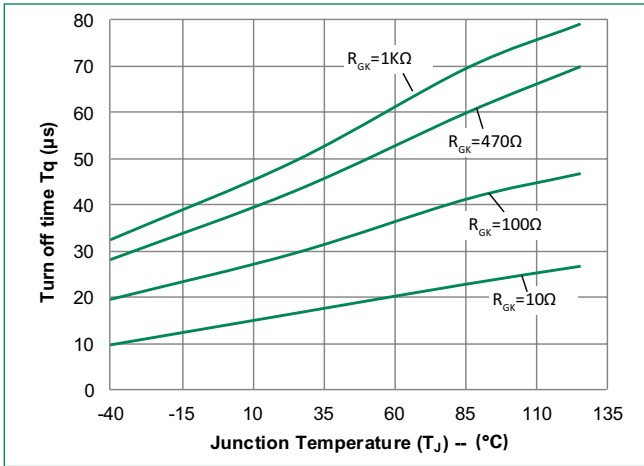
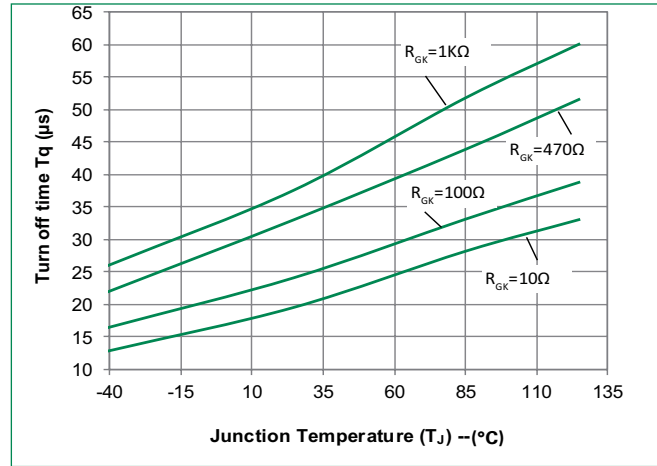
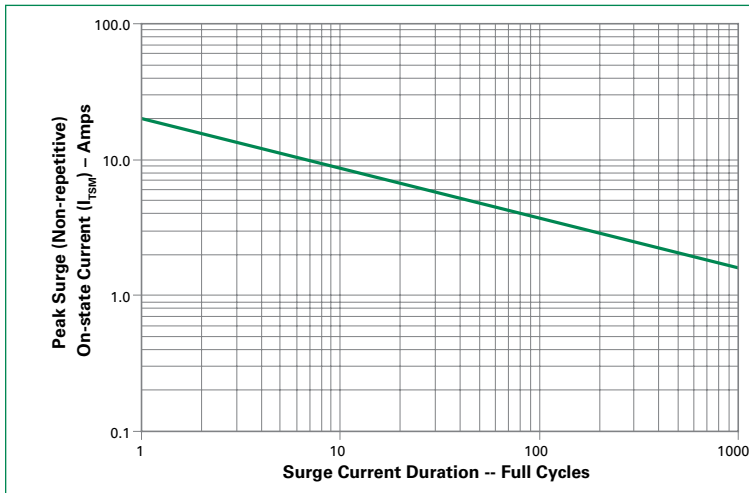
Figure 12-1: Typical DC Gate Trigger Current with R_{GK} vs. Junction Temperature for EC103x

Figure 12-2: Typical DC Gate Trigger Current with R_{GK} vs. Junction Temperature for EC103x1

Figure 13-1: Typical DC Holding Current with R_{GK} vs. Junction Temperature for EC103x

Figure 13-2: Typical DC Holding Current with R_{GK} vs. Junction Temperature for EC103x1

Figure 14-1: Typical Static dv/dt with R_{GK} vs. Junction Temperature for EC103x

Figure 14-2: Typical Static dv/dt with R_{GK} vs. Junction Temperature for EC103x1


Figure 15-1: Typical turn off time with R_{GK} vs. Junction Temperature for EC103x

Figure 15-2: Typical turn off time with R_{GK} vs. Junction Temperature for EC103x1

Figure 16: Surge Peak On-State Current vs. Number of Cycles


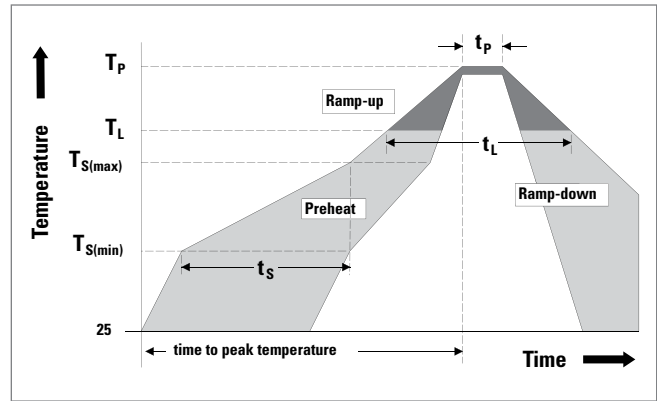
SUPPLY FREQUENCY: 60 Hz Sinusoidal
 LOAD: Resistive
 RMS On-State Current: $I_{T(RMS)}$: Maximum Rated Value at Specified Case Temperature

Notes:

1. Gate control may be lost during and immediately following surge current interval.
2. Overload may not be repeated until junction temperature has returned to steady-state rated value.

Soldering Parameters

| | | |
|--|------------------------------------|-------------------------|
| Reflow Condition | | Pb – Free assembly |
| Pre Heat | - Temperature Min ($T_{s(min)}$) | 150°C |
| | - Temperature Max ($T_{s(max)}$) | 200°C |
| | - Time (min to max) (t_s) | 60 – 180 secs |
| Average ramp up rate (Liquidus Temp) (T_L) to peak | | 5°C/second max |
| $T_{s(max)}$ to T_L - Ramp-up Rate | | 5°C/second max |
| Reflow | - Temperature (T_L) (Liquidus) | 217°C |
| | - Time (t_L) | 60 – 150 seconds |
| Peak Temperature (T_p) | | 260 ^{+0/-5} °C |
| Time within 5°C of actual peak Temperature (t_p) | | 20 – 40 seconds |
| Ramp-down Rate | | 5°C/second max |
| Time 25°C to peak Temperature (T_p) | | 8 minutes Max. |
| Do not exceed | | 280°C |



Physical Specifications

| | |
|------------------------|--|
| Terminal Finish | 100% Matte Tin-plated/Pb-free Solder Dipped |
| Body Material | UL Recognized compound meeting flammability rating V-0 |
| Lead Material | Copper Alloy |

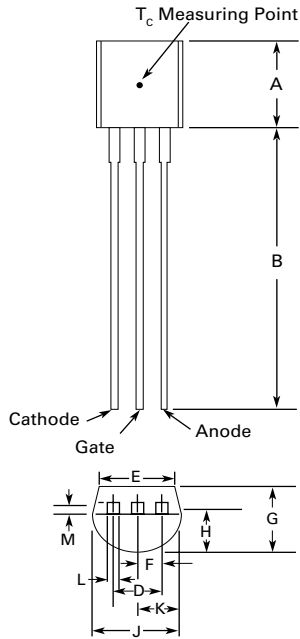
Design Considerations

Careful selection of the correct component for the application's operating parameters and environment will go a long way toward extending the operating life of the Thyristor. Good design practice should limit the maximum continuous current through the main terminals to 75% of the component rating. Other ways to ensure long life for a power discrete semiconductor are proper heat sinking and selection of voltage ratings for worst case conditions. Overheating, overvoltage (including dv/dt), and surge currents are the main killers of semiconductors. Correct mounting, soldering, and forming of the leads also help protect against component damage.

Environmental Specifications

| Test | Specifications and Conditions |
|----------------------------------|--|
| AC Blocking | MIL-STD-750, M-1040, Cond A Applied Peak AC voltage @ 110°C for 1008 hours |
| Temperature Cycling | MIL-STD-750, M-1051, 100 cycles; -40°C to +150°C; 15-min dwell-time |
| Temperature/Humidity | EIA / JEDEC, JESD22-A101 1008 hours; 320V - DC; 85°C; 85% rel humidity |
| High Temp Storage | MIL-STD-750, M-1031, 1008 hours; 150°C |
| Low-Temp Storage | 1008 hours; -40°C |
| Resistance to Solder Heat | MIL-STD-750 Method 2031 |
| Solderability | ANSI/J-STD-002, category 3, Test A |
| Lead Bend | MIL-STD-750, M-2036 Cond E |

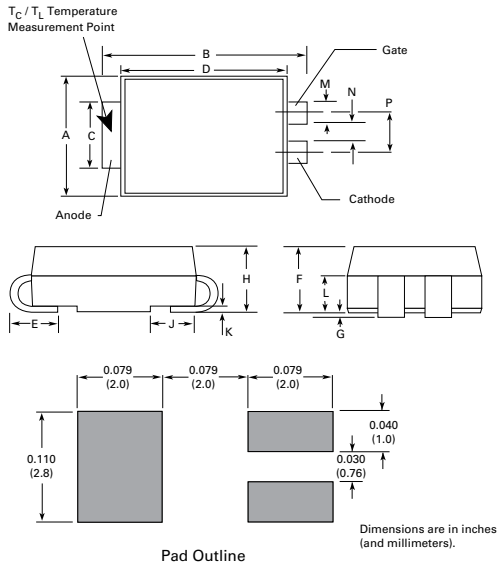
Dimensions – TO-92 (E Package)



| Dimension | Inches | | Millimeters | |
|-----------|--------|-------|-------------|------|
| | Min | Max | Min | Max |
| A | 0.176 | 0.196 | 4.47 | 4.98 |
| B | 0.500 | - | 12.70 | - |
| D | 0.095 | 0.105 | 2.41 | 2.67 |
| E | 0.150 | - | 3.81 | - |
| F | 0.046 | 0.054 | 1.16 | 1.37 |
| G | 0.135 | 0.145 | 3.43 | 3.68 |
| H | 0.088 | 0.096 | 2.23 | 2.44 |
| J | 0.176 | 0.186 | 4.47 | 4.73 |
| K | 0.088 | 0.096 | 2.23 | 2.44 |
| L | 0.013 | 0.019 | 0.33 | 0.48 |
| M | 0.013 | 0.017 | 0.33 | 0.43 |

All leads insulated from case. Case is electrically nonconductive.

Dimensions – Compak (C Package)



| Dimension | Inches | | Millimeters | |
|-----------|--------|-------|-------------|------|
| | Min | Max | Min | Max |
| A | 0.130 | 0.156 | 3.30 | 3.95 |
| B | 0.201 | 0.220 | 5.10 | 5.60 |
| C | 0.077 | 0.087 | 1.95 | 2.20 |
| D | 0.159 | 0.181 | 4.05 | 4.60 |
| E | 0.030 | 0.063 | 0.75 | 1.60 |
| F | 0.075 | 0.096 | 1.90 | 2.45 |
| G | 0.002 | 0.008 | 0.05 | 0.20 |
| H | 0.077 | 0.104 | 1.95 | 2.65 |
| J | 0.043 | 0.053 | 1.09 | 1.35 |
| K | 0.006 | 0.016 | 0.15 | 0.41 |
| L | 0.030 | 0.055 | 0.76 | 1.40 |
| M | 0.022 | 0.028 | 0.56 | 0.71 |
| N | 0.027 | 0.033 | 0.69 | 0.84 |
| P | 0.052 | 0.058 | 1.32 | 1.47 |

Product Selector

| Part Number | Voltage | | | | Gate Sensitivity | Type | Package |
|-------------|------------|------|------|-------|------------------|---------------|---------|
| | 400V | 600V | 800V | 1000V | | | |
| EC103 x 1 | X | X | | | 12 μ A | Sensitive SCR | TO-92 |
| EC103 x 2 | X | X | | | 50 μ A | Sensitive SCR | TO-92 |
| EC103 x | X / 2N6565 | X | | | 200 μ A | Sensitive SCR | TO-92 |
| EC103 x 3 | X | X | | | 500 μ A | Sensitive SCR | TO-92 |
| S x S1 | X | X | | | 12 μ A | Sensitive SCR | Compak |
| S x S2 | X | X | | | 50 μ A | Sensitive SCR | Compak |
| S x S | X | X | | | 200 μ A | Sensitive SCR | Compak |
| S x S3 | X | X | | | 500 μ A | Sensitive SCR | Compak |

Note: x = Voltage

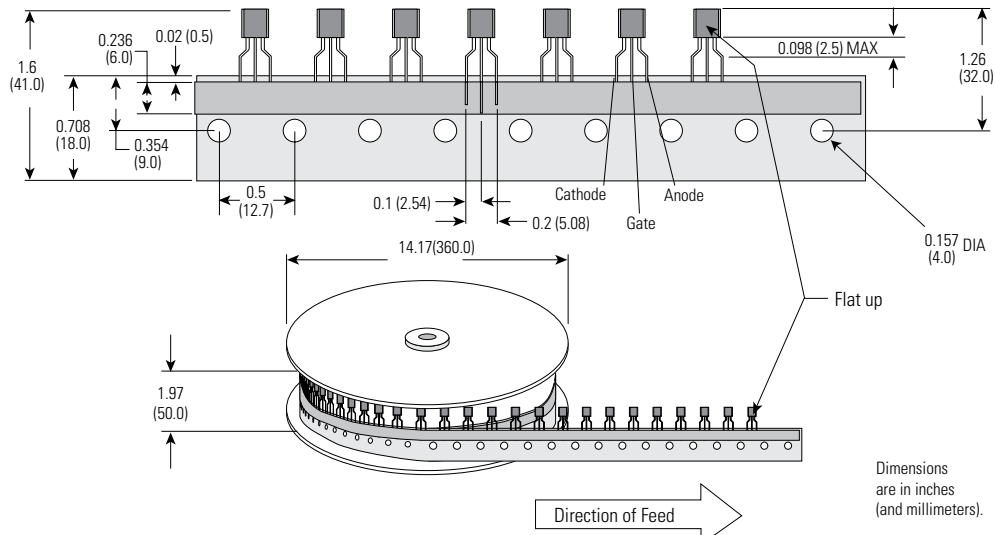
Packing Options

| Part Number | Marking | Weight | Packing Mode | Base Quantity |
|------------------|------------------|--------|------------------|---------------|
| EC103xy / 2N6565 | EC103xy / 2N6565 | 0.19 g | Bulk | 2000 |
| EC103xyRP | EC103xy | 0.19 g | Reel Pack | 2000 |
| EC103xyAP | EC103xy | 0.19 g | Ammo Pack | 2000 |
| SxSyRP | SxSy | 0.08 g | Embossed Carrier | 2500 |

Note: x = Voltage, y = sensitivity

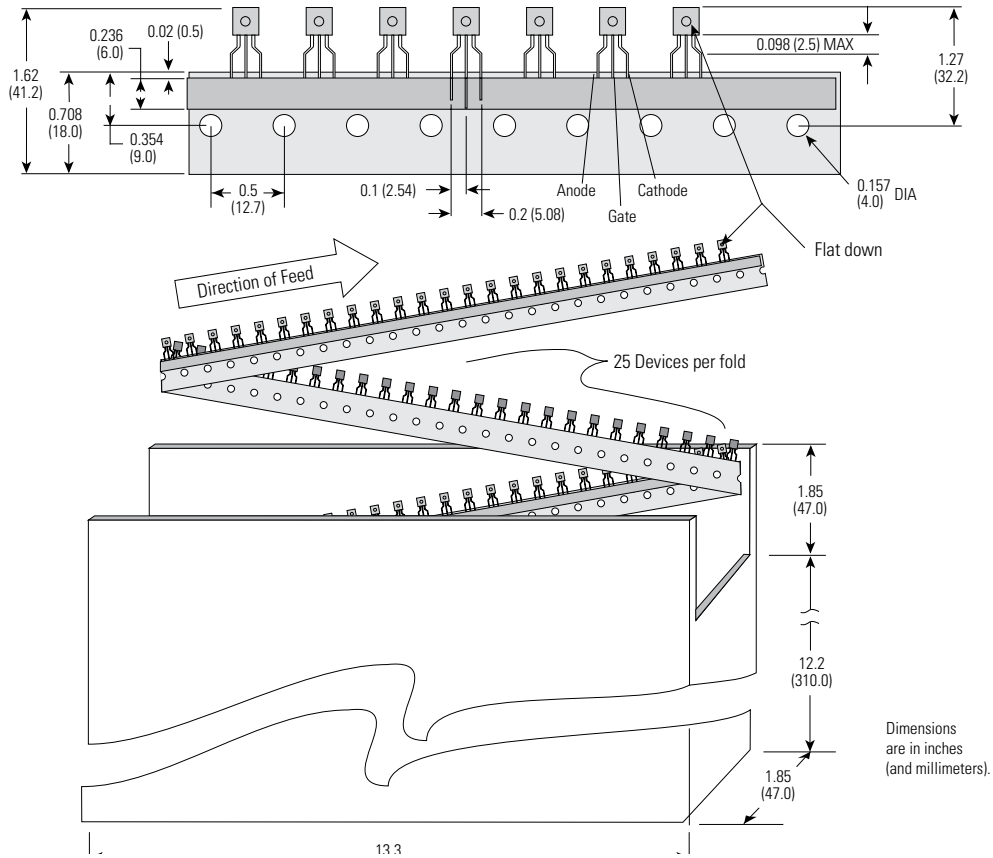
TO-92 (3-lead) Reel Pack (RP) Radial Leaded Specifications

Meets all EIA-468-C Standards



TO-92 (3-lead) Ammo Pack (AP) Radial Leaded Specifications

Meets all EIA-468-C Standards



Compak Embossed Carrier Reel Pack (RP) Specifications

Meets all EIA-481-1 Standards

